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## Magnetic behaviour of Mn<sub>x</sub>Si<sub>1-x</sub> single crystals

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## Abstract

 $Mn_xSi_{1-x}$  single crystals were grown by the vertical Bridgmann method. The lattice constant was found to increase with manganese (Mn) concentration from X-ray diffraction measurement. The concentration of Mn was determined by EPMA (Electron Probe MicroAnalyzer). We have measured the EPR linewidth w and shift  $\Delta$  H at 9.75GHz and temperature below 77K. Magnetization measurements have been performed on a MnSi single crystal under a magnetic field of 2T in the temperature range of  $4.2K \sim 300K$ .

We present the change of magnetic behaviour of  $Mn_xSi_{1-x}$  as a function of Mn composition analyzed from EPR (Electron Paramagnetic Resonance) and SQUID (Superconducting Quantum Interference Device) data in detail.

End of abstract.

## References

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